

CD4086BMS

CMOS Expandable 4-Wide 2-Input AND-OR-INVERT Gate

December 1992

Features

- Medium Speed Operation tPHL = 90ns; tPLH = 140ns (Typ.) at 10V
- High Voltage Type (20V Rating)
- INHIBIT and ENABLE Inputs
- Buffered Outputs
- 100% Tested for Quiescent Current at 20V
- Maximum Input Current of 1μA at 18V Over Full Package Temperature Range; 100nA at 18V and +25°C
- Noise Margin (Over Full Package/Temperature Range)
 - 1V at VDD = 5V
 - 2V at VDD = 10V
 - 2.5V at VDD = 15V
- Standardized Symmetrical Output Characteristics
- 5V, 10V and 15V Parametric Ratings
- Meets All Requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Series CMOS Devices"

Description

CD4086BMS contains one 4-wide 2-input AND-OR-INVERT gate with an INHIBIT/EXP input and an ENABLE/EXP input. For a 4-wide A-O-I function INHIBIT/EXP is tied to VSS and ENABLE/EXP to VDD. See Figure 2 and its associated explanation for applications where a capability greater than 4-wide is required.

The CD4076B is supplied in these 14 lead outline packages:

Braze Seal DIP H4H
Frit Seal DIP H1B
Ceramic Flatpack H4F

9 H

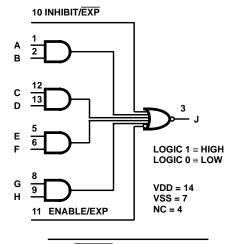
8 G

NC = NO CONNECTION

Functional Diagram

F 6

vss 7



 $J = INH + \overline{ENABLE} + AB + CD + EF + GH$

Reliability Information Absolute Maximum Ratings Thermal Resistance Ceramic DIP and FRIT Package θ_{ja} Clathack Package 80°C/W DC Supply Voltage Range, (VDD) -0.5V to +20V $_{20^{o}\text{C/W}}^{\theta_{jc}}$ (Voltage Referenced to VSS Terminals) Input Voltage Range, All Inputs -0.5V to VDD +0.5V Flatpack Package 70°C/W 20°C/W DC Input Current, Any One Input±10mA Maximum Package Power Dissipation (PD) at +125°C Operating Temperature Range.....-55°C to +125°C For TA = -55° C to $+100^{\circ}$ C (Package Type D, F, K).....500mW Package Types D, F, K, H For TA = +100°C to +125°C (Package Type D, F, K) Derate Storage Temperature Range (TSTG) -65°C to +150°C Linearity at 12mW/°C to 200mW Lead Temperature (During Soldering) +265°C Device Dissipation per Output Transistor 100mW For TA = Full Package Temperature Range (All Package Types) At Distance 1/16 \pm 1/32 Inch (1.59mm \pm 0.79mm) from case for 10s Maximum

TABLE 1. DC ELECTRICAL PERFORMANCE CHARACTERISTICS

| | | CONDITIONS (NOTE 1) | | GROUP A | | LIN | IITS | |
|--------------------------------|--------|-----------------------------------|-----------------------|-----------|----------------------|-------|-------|-------|
| PARAMETER | SYMBOL | | | SUBGROUPS | TEMPERATURE | MIN | MAX | UNITS |
| Supply Current | IDD | VDD = 20V, VIN = VDD or GND | | 1 | +25°C | - | 2 | μΑ |
| | | | | 2 | +125°C | - | 200 | μΑ |
| | | VDD = 18V, VIN = VD | D or GND | 3 | -55°C | - | 2 | μΑ |
| Input Leakage | IIL | VIN = VDD or GND | VDD = 20 | 1 | +25°C | -100 | - | nA |
| | | | | 2 | +125°C | -1000 | - | nA |
| | | | VDD = 18V | 3 | -55°C | -100 | - | nA |
| Input Leakage | IIH | VIN = VDD or GND | VDD = 20 | 1 | +25°C | - | 100 | nA |
| | | | | 2 | +125°C | - | 1000 | nA |
| | | | VDD = 18V | 3 | -55°C | - | 100 | nA |
| Output Voltage | VOL15 | VDD = 15V, No Load | • | 1, 2, 3 | +25°C, +125°C, -55°C | - | 50 | mV |
| Output Voltage | VOH15 | VDD = 15V, No Load | (Note 3) | 1, 2, 3 | +25°C, +125°C, -55°C | 14.95 | - | V |
| Output Current (Sink) | IOL5 | VDD = 5V, VOUT = 0. | 4V | 1 | +25°C | 0.53 | - | mA |
| Output Current (Sink) | IOL10 | VDD = 10V, VOUT = 0 | 0.5V | 1 | +25°C | 1.4 | - | mA |
| Output Current (Sink) | IOL15 | VDD = 15V, VOUT = 1 | 1.5V | 1 | +25°C | 3.5 | - | mA |
| Output Current (Source) | IOH5A | VDD = 5V, VOUT = 4. | VDD = 5V, VOUT = 4.6V | | +25°C | - | -0.53 | mA |
| Output Current (Source) | IOH5B | VDD = 5V, VOUT = 2. | VDD = 5V, VOUT = 2.5V | | +25°C | - | -1.8 | mA |
| Output Current (Source) | IOH10 | VDD = 10V, VOUT = 9 | 9.5V | 1 | +25°C | - | -1.4 | mA |
| Output Current (Source) | IOH15 | VDD = 15V, VOUT = 1 | 13.5V | 1 | +25°C | - | -3.5 | mA |
| N Threshold Voltage | VNTH | VDD = 10V, ISS = -10 | μΑ | 1 | +25°C | -2.8 | -0.7 | V |
| P Threshold Voltage | VPTH | VSS = 0V, IDD = 10μ/ | 4 | 1 | +25°C | 0.7 | 2.8 | V |
| Functional | F | VDD = 2.8V, VIN = VD | DD or GND | 7 | +25°C | VOH> | VOL < | V |
| | | VDD = 20V, VIN = VD | D or GND | 7 | +25°C | VDD/2 | VDD/2 | |
| | | VDD = 18V, VIN = VDD or GND | | 8A | +125°C | 1 | | |
| | | VDD = 3V, VIN = VDD | or GND | 8B | -55°C | 1 | | |
| Input Voltage Low (Note 2) | VIL | VDD = 5V, VOH > 4.5 | V, VOL < 0.5V | 1, 2, 3 | +25°C, +125°C, -55°C | - | 1.5 | V |
| Input Voltage High (Note 2) | VIH | VDD = 5V, VOH > 4.5 | V, VOL < 0.5V | 1, 2, 3 | +25°C, +125°C, -55°C | 3.5 | - | V |
| Input Voltage Low (Note 2) | VIL | VDD = 15V, VOH > 13 VOL < 1.5V | 3.5V, | 1, 2, 3 | +25°C, +125°C, -55°C | - | 4 | V |
| Input Voltage High (Note 2) | VIH | VDD = 15V, VOH > 13 VOL < 1.5V | 3.5V, | 1, 2, 3 | +25°C, +125°C, -55°C | 11 | - | V |

NOTES: 1. All voltages referenced to device GND, 100% testing being 3. For accuracy, voltage is measured differentially to VDD. Limit implemented.

is 0.050V max.

2. Go/No Go test with limits applied to inputs.

TABLE 2. AC ELECTRICAL PERFORMANCE CHARACTERISTICS

| | GROUP A | | | LIMITS | | | |
|-------------------|---------|----------------------------|-----------|---------------|-----|-----|-------|
| PARAMETER | SYMBOL | CONDITIONS (NOTES 1, 2) | SUBGROUPS | TEMPERATURE | MIN | MAX | UNITS |
| Propagation Delay | TPHL1 | VDD = 5V, VIN = VDD or GND | 9 | +25°C | - | 450 | ns |
| DATA | | | 10, 11 | +125°C, -55°C | - | 608 | ns |
| Propagation Delay | TPLH1 | VDD = 5V, VIN = VDD or GND | 9 | +25°C | - | 620 | ns |
| DATA | | | 10, 11 | +125°C, -55°C | - | 837 | ns |
| Propagation Delay | TPHL2 | VDD = 5V, VIN = VDD or GND | 9 | +25°C | - | 300 | ns |
| INHIBIT | | | 10, 11 | +125°C, -55°C | - | 405 | ns |
| Propagation Delay | TPLH2 | VDD = 5V, VIN = VDD or GND | 9 | +25°C | - | 500 | ns |
| INHIBIT | | | 10, 11 | +125°C, -55°C | - | 675 | ns |
| Transition Time | TTHL | VDD = 5V, VIN = VDD or GND | 9 | +25°C | - | 200 | ns |
| | TTLH | | 10, 11 | +125°C, -55°C | | 270 | ns |

NOTES:

- 1. CL = 50pF, RL = 200K, Input TR, TF < 20ns.
- 2. -55°C and +125°C limits guaranteed, 100% testing being implemented.

TABLE 3. ELECTRICAL PERFORMANCE CHARACTERISTICS

| | | | | | LIN | NITS | |
|-------------------------|--------|-----------------------------|-------|-------------------------|------|-------|-------|
| PARAMETER | SYMBOL | CONDITIONS | NOTES | TEMPERATURE | MIN | MAX | UNITS |
| Supply Current | IDD | VDD = 5V, VIN = VDD or GND | 1, 2 | -55°C, +25°C | - | 1 | μΑ |
| | | | | +125°C | - | 30 | μΑ |
| | | VDD = 10V, VIN = VDD or GND | 1, 2 | -55°C, +25°C | - | 2 | μΑ |
| | | | | +125°C | - | 60 | μΑ |
| | | VDD = 15V, VIN = VDD or GND | 1, 2 | -55°C, +25°C | - | 2 | μΑ |
| | | | | +125°C | - | 120 | μΑ |
| Output Voltage | VOL | VDD = 5V, No Load | 1, 2 | +25°C, +125°C, -55°C | - | 50 | mV |
| Output Voltage | VOL | VDD = 10V, No Load | 1, 2 | +25°C, +125°C, -55°C | - | 50 | mV |
| Output Voltage | VOH | VDD = 5V, No Load | 1, 2 | +25°C, +125°C, -55°C | 4.95 | - | V |
| Output Voltage | VOH | VDD = 10V, No Load | 1, 2 | +25°C, +125°C, -55°C | 9.95 | - | V |
| Output Current (Sink) | IOL5 | VDD = 5V, VOUT = 0.4V | 1, 2 | +125°C | 0.36 | - | mA |
| | | | | -55°C | 0.64 | - | mA |
| Output Current (Sink) | IOL10 | VDD = 10V, VOUT = 0.5V | 1, 2 | +125°C | 0.9 | - | mA |
| | | | | -55°C | 1.6 | - | mA |
| Output Current (Sink) | IOL15 | VDD = 15V, VOUT = 1.5V | 1, 2 | +125°C | 2.4 | - | mA |
| | | | | -55°C | 4.2 | - | mA |
| Output Current (Source) | IOH5A | VDD = 5V, VOUT = 4.6V | 1, 2 | +125°C | - | -0.36 | mA |
| | | | | -55°C | - | -0.64 | mA |
| Output Current (Source) | IOH5B | VDD = 5V, VOUT = 2.5V | 1, 2 | +125°C | - | -1.15 | mA |
| | | | | -55°C | - | -2.0 | mA |
| Output Current (Source) | IOH10 | VDD = 10V, VOUT = 9.5V | 1, 2 | +125°C | - | -0.9 | mA |
| | | | | -55°C | - | -2.6 | mA |

TABLE 3. ELECTRICAL PERFORMANCE CHARACTERISTICS (Continued)

| | | | | | LIM | IITS | |
|-------------------------|--------|-------------------------------|---|-------------------------|-----|------|-------|
| PARAMETER | SYMBOL | CONDITIONS | NOTES | TEMPERATURE | MIN | MAX | UNITS |
| Output Current (Source) | IOH15 | VDD =15V, VOUT = 13.5V | 1, 2 | +125°C | - | -2.4 | mA |
| | | | | -55°C | - | -4.2 | mA |
| Input Voltage Low | VIL | VDD = 10V, VOH > 9V, VOL < 1V | VDD = 10V, VOH > 9V, VOL < 1V 1, 2 +25°C, +125°C, -55°C | | - | 3 | V |
| Input Voltage High | VIH | VDD = 10V, VOH > 9V, VOL < 1V | 1, 2 | +25°C, +125°C, -55°C | 7 | - | V |
| Propagation Delay | TPHL1 | VDD = 10V | 1, 2, 3 | +25°C | - | 180 | ns |
| DATA | | VDD = 15V | 1, 2, 3 | +25°C | - | 120 | ns |
| Propagation Delay | TPLH1 | VDD = 10V | 1, 2, 3 | +25°C | - | 250 | ns |
| DATA | | VDD = 15V | 1, 2, 3 | +25°C | - | 180 | ns |
| Propagation Delay | TPHL2 | VDD = 10V | 1, 2, 3 | +25°C | - | 120 | ns |
| INHIBIT | | VDD = 15V | 1, 2, 3 | +25°C | - | 80 | ns |
| Propagation Delay | TPLH2 | VDD = 10V | 1, 2, 3 | +25°C | - | 200 | ns |
| INHIBIT | | VDD = 15V | 1, 2, 3 | +25°C | - | 140 | ns |
| Transition Time | TTHL1 | VDD = 10V | 1, 2, 3 | +25°C | - | 100 | ns |
| | TTLH1 | VDD = 15V | 1, 2, 3 | +25°C | - | 80 | ns |
| Input Capacitance | CIN | Any Input | 1, 2 | +25°C | - | 7.5 | pF |

NOTES:

- 1. All voltages referenced to device GND.
- 2. The parameters listed on Table 3 are controlled via design or process and are not directly tested. These parameters are characterized on initial design release and upon design changes which would affect these characteristics.
- 3. CL = 50pF, RL = 200K, Input TR, TF < 20ns.

TABLE 4. POST IRRADIATION ELECTRICAL PERFORMANCE CHARACTERISTICS

| | | | | | LIM | IITS | |
|------------------------------|--------------|---|------------|-------------|-------|--------------------------|-------|
| PARAMETER | SYMBOL | CONDITIONS | NOTES | TEMPERATURE | MIN | MAX | UNITS |
| Supply Current | IDD | $VDD = 20V, VIN = VDD \text{ or GND} \qquad 1, 4 \qquad +25^{\circ}C$ | | +25°C | - | 7.5 | μΑ |
| N Threshold Voltage | VNTH | VDD = 10V, ISS = -10μA | 1, 4 | +25°C | -2.8 | -0.2 | V |
| N Threshold Voltage Delta | ΔVTN | VDD = 10V, ISS = -10μA 1, 4 | | +25°C | - | ±1 | V |
| P Threshold Voltage | VTP | VSS = 0V, IDD = 10μA | 1, 4 | +25°C | 0.2 | 2.8 | V |
| P Threshold Voltage Delta | ΔVTP | VSS = 0V, IDD = 10μA | 1, 4 | +25°C | - | ±1 | V |
| Functional | F | VDD = 18V, VIN = VDD or GND | 1 | +25°C | VOH > | VOL < | V |
| | | VDD = 3V, VIN = VDD or GND | | | VDD/2 | VDD/2 | |
| Propagation Delay Time | TPHL TPLH | VDD = 5V | 1, 2, 3, 4 | +25°C | - | 1.35 x +25°C Limit | ns |

NOTES: 1. All voltages referenced to device GND.

3. See Table 2 for +25°C limit.

2. CL = 50pF, RL = 200K, Input TR, TF < 20ns.

4. Read and Record

TABLE 5. BURN-IN AND LIFE TEST DELTA PARAMETERS +25°C

| PARAMETER | SYMBOL | DELTA LIMIT |
|-------------------------|--------|--------------------------|
| Supply Current - MSI-1 | IDD | ± 0.2μA |
| Output Current (Sink) | IOL5 | ± 20% x Pre-Test Reading |
| Output Current (Source) | IOH5A | ± 20% x Pre-Test Reading |

TABLE 6. APPLICABLE SUBGROUPS

| CONFO | RMANCE GROUP | MIL-STD-883 METHOD | GROUP A SUBGROUPS | READ AND RECORD |
|----------------------------|------------------|-----------------------|---------------------------------------|------------------------------|
| Initial Test (Pre Burn-In) | | 100% 5004 | 1, 7, 9 | IDD, IOL5, IOH5A |
| Interim Test | 1 (Post Burn-In) | 100% 5004 | 1, 7, 9 | IDD, IOL5, IOH5A |
| Interim Test | 2 (Post Burn-In) | 100% 5004 | 1, 7, 9 | IDD, IOL5, IOH5A |
| PDA (Note | : 1) | 100% 5004 | 1, 7, 9, Deltas | |
| Interim Test | 3 (Post Burn-In) | 100% 5004 | 1, 7, 9 | IDD, IOL5, IOH5A |
| PDA (Note | : 1) | 100% 5004 | 1, 7, 9, Deltas | |
| Final Test | | 100% 5004 | 2, 3, 8A, 8B, 10, 11 | |
| Group A | | Sample 5005 | 1, 2, 3, 7, 8A, 8B, 9, 10, 11 | |
| Group B Subgroup B-5 | | Sample 5005 | 1, 2, 3, 7, 8A, 8B, 9, 10, 11, Deltas | Subgroups 1, 2, 3, 9, 10, 11 |
| Subgroup B-6 | | Sample 5005 | 1, 7, 9 | |
| Group D | | Sample 5005 | 1, 2, 3, 8A, 8B, 9 | Subgroups 1, 2 3 |

NOTE: 1.5% Parameteric, 3% Functional; Cumulative for Static 1 and 2.

TABLE 7. TOTAL DOSE IRRADIATION

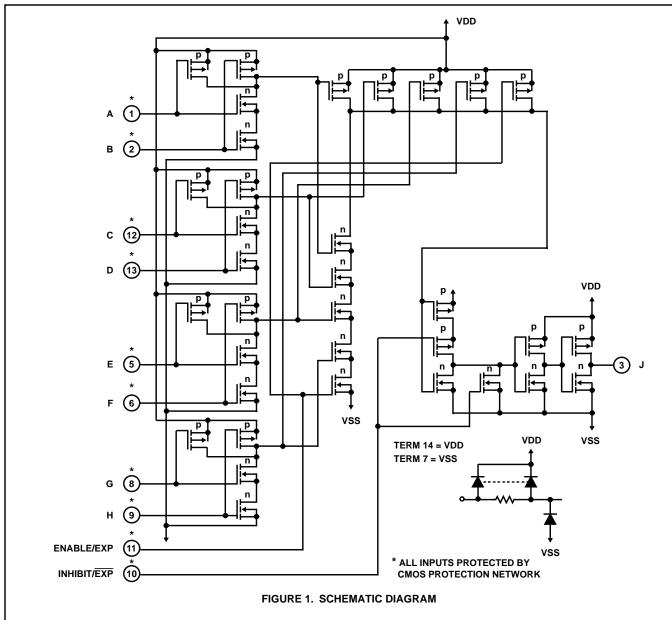
| | MIL-STD-883 | ŢE | ST | READ AND | RECORD |
|--------------------|-------------|-----------|------------|-----------|------------|
| CONFORMANCE GROUPS | METHOD | PRE-IRRAD | POST-IRRAD | PRE-IRRAD | POST-IRRAD |
| Group E Subgroup 2 | 5005 | 1, 7, 9 | Table 4 | 1, 9 | Table 4 |

TABLE 8. BURN-IN AND IRRADIATION TEST CONNECTIONS

| | | | | | OSCILLATOR | |
|----------------------------|------|--------------|--------------------|----------------|-----------------------------|--------|
| FUNCTION | OPEN | GROUND | VDD | 9V \pm -0.5V | 50kHz | 25kHz |
| Static Burn-In 1 Note 1 | 3, 4 | 1, 2, 5 - 13 | 14 | | | |
| Static Burn-In 2 Note 1 | 3, 4 | 7 | 1, 2, 5, 6, 8 - 14 | | | |
| Dynamic Burn- In Note 1 | 4 | 7 | 14 | 3 | 1, 2, 5, 6, 8, 9, 12, 13 | 10, 11 |
| Irradiation Note 2 | 3, 4 | 7 | 1, 2, 5, 6, 8 - 14 | | | |

NOTES:

- 1. Each pin except VDD and GND will have a series resistor of 10K \pm 5%, VDD = 18V \pm 0.5V
- 2. Each pin except VDD and GND will have a series resistor of 47K \pm 5%; Group E, Subgroup 2, sample size is 4 dice/wafer, 0 failures, VDD = $10V \pm 0.5V$



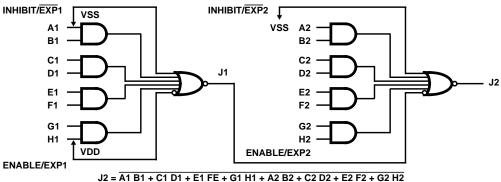


FIGURE 2. TWO CD4086BMS'S CONNECTED AS AN 8-WIDE 2-INPUT A-O-I GATE

Figure 2 above shows two CD4086's utilized to obtain 8-wide 2-input A-O-I function. The output (J1) of one CD4086 is fed directly to the ENABLE/EXP2 line of the second CD4086. In a similar fashion, any NAND gate output can be fed directly

into the ENABLE/EXP input to obtain a 5-wide A-O-I function. In addition, and AND gate output can be fed directly into the INHIBIT/EXP input with the same result.

Typical Performance Characteristics

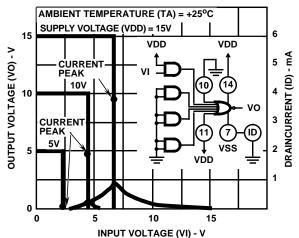


FIGURE 3. TYPICAL VOLTAGE AND CURRENT TRANSFER CHARACTERISTICS

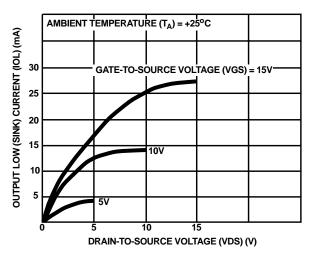


FIGURE 5. TYPICAL OUTPUT LOW (SINK) CURRENT CHARACTERISTICS

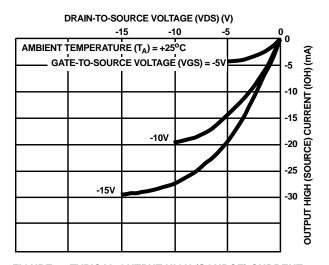


FIGURE 7. TYPICAL OUTPUT HIGH (SOURCE) CURRENT CHARACTERISTICS

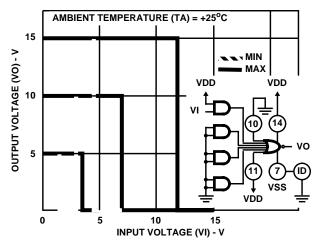


FIGURE 4. MINIMUM AND MAXIMUM VOLTAGE TRANSFER CHARACTERISTICS

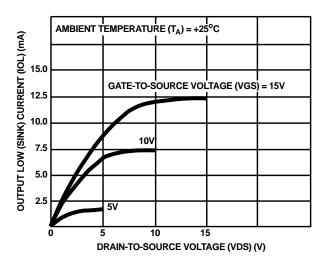


FIGURE 6. MINIMUM OUTPUT LOW (SINK) CURRENT CHARACTERISTICS

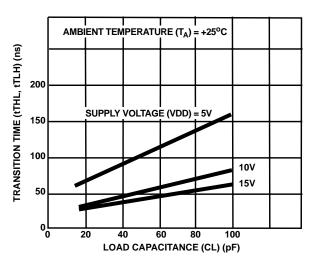


FIGURE 8. TYPICAL TRANSITION TIME vs LOAD CAPACITANCE

Typical Performance Characteristics (Continued)

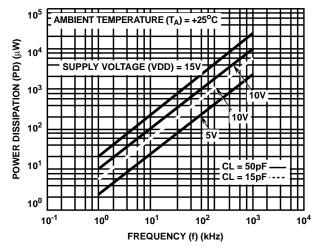


FIGURE 9. TYPICAL POWER DISSIPATION vs FREQUENCY

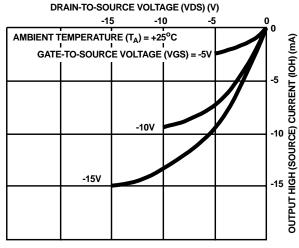


FIGURE 10. MINIMUM OUTPUT HIGH (SOURCE) CURRENT CHARACTERISTICS

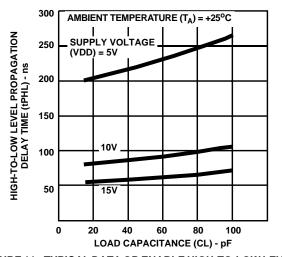


FIGURE 11. TYPICAL DATA OR ENABLE HIGH-TO-LOW LEVEL PROPAGATION DELAY TIME vs LOAD CAPACITANCE

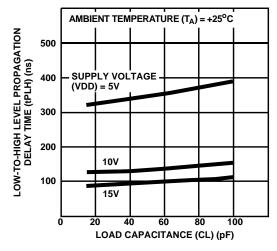


FIGURE 12. TYPICAL DATA OR ENABLE LOW-TO-HIGH LEVEL PROPAGATION DELAY TIME vs LOAD CAPACITANCE

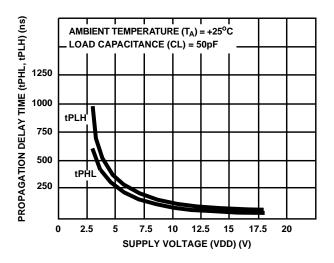
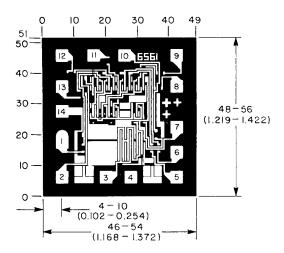


FIGURE 13. TYPICAL DATA OR ENABLE PROPAGATION DELAY TIME vs SUPPLY VOLTAGE

Chip Dimensions and Pad Layout



Dimensions in parenthesis are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils (10⁻³ inch).

METALLIZATION: Thickness: 11kÅ – 14kÅ, AL.

PASSIVATION: 10.4kÅ - 15.6kÅ, Silane

BOND PADS: 0.004 inches X 0.004 inches MIN **DIE THICKNESS:** 0.0198 inches - 0.0218 inches

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